Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/677,094	QIAN ET AL.	
Examiner	**Art Unit**	
John L. Goodrow	1756	

SEARCHED			
Class	Subclass	Date	Examiner
430	115	4/1/2006	JG
	117		
399	273		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
430	**115**	4/1/2006	**JG**
	117		
399	273		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor name search and east	4/1/2006	JG